

<b>Notice of References Cited</b>	Application/Control No. 09/895,605		Applicant(s)/Patent Under Reexamination STEFER ET AL.	
	Examiner Kelvin E Booker		Art Unit 2121	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,021,397	02-2000	Jones et al.	705/36
*	B	US-2002/0004775	01-2002	Kossovsky et al.	705/37
*	C	US-2003/0126058	07-2003	Hunter, Brian A.	705/36
*	D	US-2004/0103056	05-2004	Ikeda et al.	705/038
*	E	US-2003/0014356	01-2003	Browne et al.	705/38
*	F	US-6,282,520	08-2001	Schirripa, Felix	705/36
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Ogryczak et al., "From Stochastic Dominance to Mean-Risk Models: Semideviations as Risk Measures", International Institute for Applied Systems Analysis, Interim Report IR-97-027, June 1997.			
	V	Pininski et al., "A Risk and Decision Model for the Optimal Investment in Plant Protection", Portland International Conference on Management and Technology, July 1997.			
	W	Amir et al., "Identifying a Time-dependent Covariate Effect in the Additive Risk Model", Retrieved from the Internet: <a href="http://citeseer.ist.psu.edu/336826.html">http://citeseer.ist.psu.edu/336826.html</a> .			
	X	Chen et al., "An Integrative Approach to Modeling the World Equity Market", Citeseer online database, June 2000.			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.